

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10587850	MAYER ET AL.
Examiner	Art Unit	
DEREK S CHAPEL	2872	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the lack of unity	8/25/2008	DSC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/D. S. C./
Examiner Art Unit 2872